Search Notes	•	
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Application/Control No.	Applicant(s)/Patent under Reexamination
09/454,941	KIRK, DAVID B.
Examiner	Art Unit
Harold Kim	2181

SEARCHED			
Class	Subclass	Date	Examiner
710	241, 52, 57, 29	4/2/2006	НК
370	378	4/2/2006	НК
345	501	4/2/2006	НК
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
USPAT, USPGPUB, JPO, EPO, IEEE, NPL, see attached search note; inventor search on eDAN	4/2/2006	нк
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